

AUTOMOTIVE CURRENT TRANSDUCER OPEN LOOP TECHNOLOGY HAH1DRW 100-S/SP5, HAH1DRW 200-S/SP5, HAH1DRW 300-S/SP5, HAH1DRW 400-S/SP5, HAH1DRW 500-S/SP5, HAH1DRW 600-S/SP5, HAH1DRW 700-S/SP5, HAH1DRW 800-S/SP5, HAH1DRW 900-S/SP5, HAH1DRW 1000-S/SP5, HAH1DRW 1100-S/SP5, HAH1DRW 1200-S/SP5, HAH1DRW 1500-S/SP5





Introduction

The HAH1DRW family for the electronic measurement of DC, AC or pulsed currents in high power and low voltage automotive applications with galvanic separation between the primary circuit (high power) and the secondary circuit (electronic circuit).

The HAH1DRW family gives you the choice of having different current measuring ranges in the same housing.

Features

- Ratiometric transducer
- Open Loop transducer using the Hall effect •
- Low voltage application
- Unipolar +5 V DC power supply •
- Maximum RMS primary admissible current: defined by • busbar to have T < +150 °C
- Operating temperature range: -40 °C < T < 125 °C
- Output voltage: full ratio-metric (in sensitivity and offset).

Special features

- Additional coating of the ASIC pins
- Compressor limiter for M4 screw.

Advantages

- Excellent accuracy
- Very good linearity
- Very low thermal offset drift
- Very low thermal sensitivity drift •
- Galvanic separation •
- High frequency bandwidth •
- Non intrusive solution.

Automotive applications

- **Electrical Power Steering**
- Starter Generators
- Converters
- **Battery Management**
- Motor drive application.



Principle of HAH1DRW family

The open loop transducers use a Hall effect integrated circuit. The magnetic flux density B, contributing to the rise of the Hall

voltage, is generated by the primary current I_{p} to be measured.

The current to be measured $I_{\rm p}$ is supplied by a current source i.e. battery or generator (Figure 1).

Within the linear region of the hysteresis cycle, *B* is proportional to:

 $B(I_{\rm P}) = a \times I_{\rm P}$ The Hall voltage is thus expressed by:

$$U_{\text{Hall}} = (c_{\text{Hall}} / d) \times I_{\text{Hall}} \times a \times I_{\text{P}}$$

Except for I_{p} , all terms of this equation are constant. Therefore:

× I _P
constant
constant
Hall coefficient
thickness of the Hall plate
current across the Hall plates

The measurement signal $U_{\mbox{\tiny Hall}}$ amplified to supply the user output voltage or current.

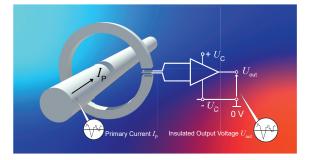


Fig. 1: Principle of the open loop transducer.

N° 97.G8.34.005.0,N° 97.G8.44.005.0,N° 97.G8.46.005.0,N° 97.G8.48.005.0,N° 97.G8.50.005.0,N° 97.G8.52.005.0,N° 97.G8.54.005.0,N° 97.G8.56.005.0,N° 97.G8.56.005.0,N° 97.G8.65.005.0,N° 97.0,N° 97.0,N° 97.0,N° 97.0,N° 97.0,N° 97.0,N° 97.0,N° 97.0,N°

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• $U_{out} > U_{o}$ when I_{P} flows in the positive direction (see arrow

GND

ypical application

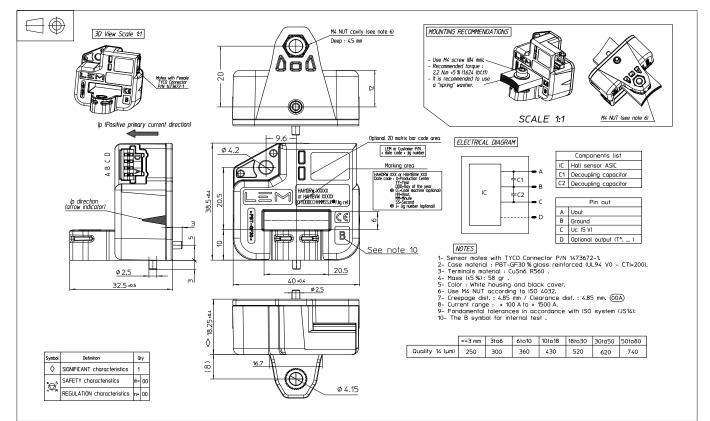
 R_{\perp}

l

matic interface

+5 V

Dimensions (in mm)



Remark

I_{pm}

Primary

Current

on drawing).

System architecture (example)

+5 \

÷

С 2

÷

LEM Transducer

D

 $C_1 < 2.2 \text{ nF EMC protection (optional)}$

Magnetic Core

RC Low pass filter (optional)

On board diagnostic

Mechanical characteristics

•	Plastic case	PBT GF 30
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- Magnetic core
 FeSi wound core
- Mass 58 g ±5 %
- Pins Brass tin plated
- IP level

Mounting recommendation

Connector type TYCO connector P/N 1473672-1

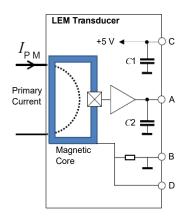
IPx 2.

С

D

• Assembly torque max 2.2 N·m ±5 %

Electronic schematic



Components list								
IC	Hall sensor ASIC							
C1	Decoupling capacitor	47 nF						
C2	EMC protection capacitor	4.7 nF						
· · ·								
Pin out								
A	$U_{\rm out}$							
B GND								

U_c (5 V)

GND

4.7 11	$R_{\rm L}$ > 10 kΩ. Resis	tor for signal line	e diagnostic (optional)
:		Ĩ	I
out	$U_{\rm out}$	Diagnostic	
10	Open circuit	II = II	

U _{out}	Diagnostic
Open circuit	$U_{\rm IN} = U_{\rm C}$
Short GND	$U_{\rm IN}$ = 0 V

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Absolute ratings (not operating)

HAH1DRW 100-S/SP5...1500-S/SP5

Parameter	Symbol	Unit	Specification			Conditions	
Parameter	Symbol	Unit	Min	Typical	Мах	Conditions	
Maximum supply voltage	$U_{ m C\ max}$	V	-0.5		8	1)	
Ambient storage temperature	T _{Ast}	°C	-40		125		
Electrostatic discharge voltage (HBM)	$U_{\rm ESD\;HBM}$	kV			8		
Maximum admissible vibration (random RMS)	γ _{max}	m·s⁻²			27.1	10 to 1000 Hz, −40 °C to 125 °C	
RMS voltage for AC insulation test	$U_{\rm d}$	kV			2.5	50 Hz, 1 min	
Creepage distance	d _{Cp}	mm	4.85				
Clearance	d _{ci}	mm	4.85				
Comparative traking index	CTI			PLC 3			
Maximum output current	I _{out max}	mA	-10		10		
Maximum output voltage	$U_{\rm outmax}$	V	-0.5		U _c + 0.5		

Operating characteristics in nominal range (I_{PN})

Devenueter	Oumbal	Unit	Specification			Oraștitare	
Parameter	Symbol		Min	Typical	Max	Conditions	
Supply voltage	Uc	V	4.75	5	5.25		
Ambient operating temperature	T _A	°C	-40		125		
Output voltage (Analog)	$U_{\rm out}$	V	U _{out} = (U _c / 5) × (U	$(+ S \times I_P)$		
Offset voltage	Uo	V		2.5			
Current consumption	I _c	mA		20	25		
Load resistance	RL	ΚΩ	10				
Output internal resistance	R _{out}	Ω		1	10		
		Perf	formanc	e Data			
Ratiometricity error	ε _r	%		±0.5			
Magnetic offset voltage	U _{om}	mV		±2		@ $U_{\rm c}$ = 5 V, @ $T_{\rm A}$ = 25 °C	
Linearity error	εL	%	-1		1	% of full scale	
Average temperature coefficient of $U_{\rm OE}$	TCU _{OEAV}	mV/°C		±0.04			
Average temperature coefficient of S	TCS AV	%/°C		±0.02			
Delay time to 90 % of the final output value for $I_{\rm PN}$ step	t _{D 90}	μs		2	6	d <i>i/</i> d <i>t</i> = 100 A / μs	
Frequency bandwidth	BW	kHz	40			@ -3 dB	
Peak-to-peak noise voltage	U _{no pp}	mV			14	DC to 1 MHz	
Output RMS noise voltage	Uno	mV			2.2		
Phase shift	Δφ	٥	-4			DC to 1 KHz	

<u>Note</u>: ¹⁾ Exceeding 6.5 V may temporarily reconfigure the device until next power on.



IAH1DRW 100-S/SP5 HAH1DRW 100-S/SP51500-S/SP5									
Deremeter	Symbol	Unit		Specification	1	Conditions			
Parameter	Symbol	Unit	Min	Typical	Max	Conditions			
Performance Data									
Primary current, measuring range	I _{PM}	А	-100		100				
Primary nominal RMS current	I _{PN}	А	-100		100				
Sensitivity	S	mV/A		20		@ T _A = 25 °C			
Sensitivity error	ε _s	%		±0.6		@ T _A = 25 °C, @ U _C = 5 V			
Electrical offset voltage	U _{OE}	mV		±3		@ T _A = 25 °C, @ U _C = 5 V			

HAH1DRW 200-S/SP5

Parameter	Symbol	Unit		Specification		Conditions			
	Symbol	Unit	Min	Typical	Max	Conditions			
Performance Data									
Primary current, measuring range	I _{PM}	A	-200		200				
Primary nominal RMS current	I _{PN}	A	-200		200				
Sensitivity	S	mV/A		10		@ T _A = 25 °C			
Sensitivity error	ε _s	%		±0.6		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V			
Electrical offset voltage	U _{oe}	mV		±3		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V			

HAH1DRW 300-S/SP5

Parameter	Symbol	Unit		Specification]	Conditions				
			Min	Typical	Max	Conditions				
Performance Data										
Primary current, measuring range	I _{PM}	A	-300		300					
Primary nominal RMS current	I _{PN}	А	-300		300					
Sensitivity	S	mV/A		6.667		@ T _A = 25 °C				
Sensitivity error	ε _s	%		±0.6		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V				
Electrical offset voltage	U _{oe}	mV		±3		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V				

HAH1DRW 400-S/SP5

Parameter	Symbol	Unit		Specificatior	า	Conditions				
	Symbol		Min	Typical	Max	Conditions				
Performance Data										
Primary current, measuring range	I _{PM}	А	-400		400					
Primary nominal RMS current	I _{PN}	А	-400		400					
Sensitivity	S	mV/A		5		@ T _A = 25 °C				
Sensitivity error	<i>E</i> s	%		±0.6		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V				
Electrical offset voltage	U _{oe}	mV		±3		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V				

HAH1DRW 500-S/SP5

Parameter	Symbol	Unit		Specification		Conditions			
			Min	Typical	Max	Conditions			
Performance Data									
Primary current, measuring range	I _{PM}	A	-500		500				
Primary nominal RMS current	I _{PN}	А	-500		500				
Sensitivity	S	mV/A		4		@ T _A = 25 °C			
Sensitivity error	ε _s	%		±0.6		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V			
Electrical offset voltage	U _{oe}	mV		±3		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V			

HAH1DRW 600-S/SP5

Parameter	Symbol	Unit	Specification			Conditions
	Symbol		Min	Typical	Max	Conditions
		Perform	nance Data			
Primary current, measuring range	I _{PM}	А	-600		600	
Primary nominal RMS current	I _{PN}	А	-600		600	
Sensitivity	S	mV/A		3.333		@ T _A = 25 °C
Sensitivity error	€ _s	%		±0.6		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V
Electrical offset voltage	U _{OE}	mV		±3		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V
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HAH1DRW 700-S/SP5 HAH1DRW 100-S/SP51500-S						
Parameter	Symbol	Unit	Specification			
	Symbol		Min	Typical	Max	Conditions
		Perform	nance Data			
Primary current, measuring range	I _{PM}	A	-700		700	
Primary nominal RMS current	I _{PN}	A	-700		700	
Sensitivity	S	mV/A		2.857		@ T _A = 25 °C
Sensitivity error	ε _s	%		±0.6		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V
Electrical offset voltage	U _{OE}	mV		±3		@ T _A = 25 °C, @ U _C = 5 V

HAH1DRW 800-S/SP5

Parameter	Symbol	Unit	Specification			Conditions
	Symbol		Min	Typical	Max	Conditions
		Perform	nance Data			
Primary current, measuring range	I _{PM}	A	-800		800	
Primary nominal RMS current	I _{PN}	A	-800		800	
Sensitivity	S	mV/A		2.5		@ T _A = 25 °C
Sensitivity error	ε _s	%		±0.6		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V
Electrical offset voltage	U _{oe}	mV		±3		@ T _A = 25 °C, @ U _C = 5 V

HAH1DRW 900-S/SP5

Parameter	Symbol	Unit	Specification			Conditions
	Symbol		Min	Typical	Max	Conditions
		Perform	nance Data			
Primary current, measuring range	I _{PM}	А	-900		900	
Primary nominal RMS current	I _{PN}	А	-900		900	
Sensitivity	S	mV/A		2.222		@ T _A = 25 °C
Sensitivity error	ε _s	%		±0.6		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V
Electrical offset voltage	U _{oe}	mV		±3		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V

HAH1DRW 1000-S/SP5

Parameter	Symbol	Unit	Specification			Conditions
Farameter	Symbol		Min	Typical	Max	Conditions
		Perform	nance Data			
Primary current, measuring range	I _{PM}	А	-1000		1000	
Primary nominal RMS current	I _{PN}	А	-1000		1000	
Sensitivity	S	mV/A		2		@ T _A = 25 °C
Sensitivity error	ε _s	%		±0.7		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V
Electrical offset voltage	U _{oe}	mV		±3		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V

HAH1DRW 1100-S/SP5

Parameter	Symbol	Unit	Specification			Conditions
Farameter	Symbol		Min	Typical	Max	Conditions
		Perforr	nance Data			
Primary current, measuring range	I _{PM}	A	-1100		1100	
Primary nominal RMS current	I _{pn}	A	-1100		1100	
Sensitivity	S	mV/A		1.818		@ T _A = 25 °C
Sensitivity error	ε _s	%		±0.7		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V
Electrical offset voltage	U _{oe}	mV		±3		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V

HAH1DRW 1200-S/SP5

Deremeter	Sympol	Unit	Specification			Conditions
Parameter	Symbol		Min	Typical	Max	Conditions
		Perfor	mance Data			
Primary current, measuring range	I _{PM}	А	-1200		1200	
Primary nominal RMS current	I _{PN}	А	-1200		1200	
Sensitivity	S	mV/A		1.67		@ T _A = 25 °C
Sensitivity error	Ês	%		±0.7		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V
Electrical offset voltage	U _{OE}	mV		±3		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V
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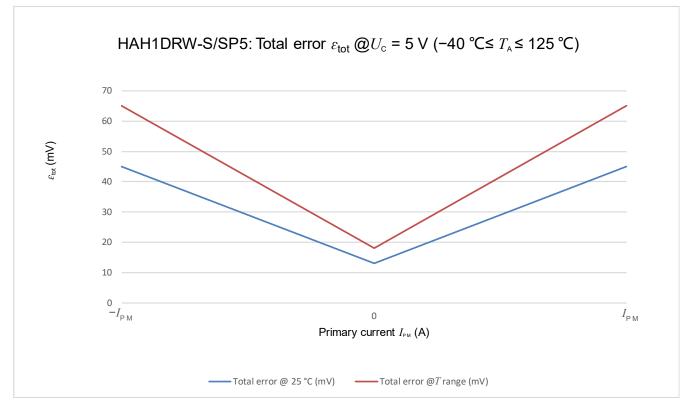


HAH1DRW 1500-S/SP5 HAH1DRW 100-S/SP51500						
Parameter	Symbol	Unit		Specificatior	ı I	
	Symbol	Unit	Min	Typical	Max	Conditions
		Perform	nance Data			
Primary current, measuring range	I _{PM}	A	-1500		1500	
Primary nominal RMS current	I _{PN}	A	-1500		1500	
Sensitivity	S	mV/A		1.33		@ T _A = 25 °C
Sensitivity error	€ _s	%		±0.9		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V
Electrical offset voltage	UOE	mV		±3.6		@ T _A = 25 °C, @ U _C = 5 V

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Total error \mathcal{E}_{tot}

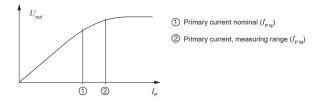


	Total error ε_{tot} specification							
I _Р (А)	<i>T</i> _A =25 °C	, U _c =5 V	−40 °C ≤ <i>T</i> _A ≤12	25 °C, U _c = 5 V				
— I _{РМ}	45 mV	2.25 %	65 mV	3.25 %				
0	13 mV	0.65 %	18 mV	0.90 %				
I _{PM}	45 mV	2.25 %	65 mV	3.25 %				



PERFORMANCES PARAMETERS DEFINITIONS

Primary current definition:



Definition of typical, minimum and maximum values:

Minimum and maximum values for specified limiting and safety conditions have to be understood as such as values shown in "typical" graphs. On the other hand, measured values are part of a statistical distribution that can be specified by an interval with upper and lower limits and a probability for measured values to lie within this interval. Unless otherwise stated (e.g. "100 % tested"), the LEM definition for such intervals designated with "min" and "max" is that the probability for values of samples to lie in this interval is 99.73 %. For a normal (Gaussian) distribution, this corresponds to an interval between -3 sigma and +3 sigma. If "typical" values are not obviously mean or average values, those values are defined to delimit intervals with a probability of 68.27 %, corresponding to an interval between -sigma and +sigma for a normal distribution. Typical, minimum and maximum values are determined during the initial characterization of a product.

Output noise voltage:

The output voltage noise is the result of the noise floor of the Hall elements and the linear amplifier.

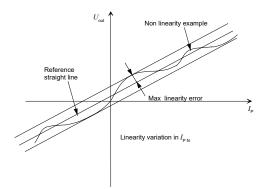
Magnetic offset:

The magnetic offset is the consequence of an any current on the primary side. It's defined after a stated excursion of primary current.

Linearity:

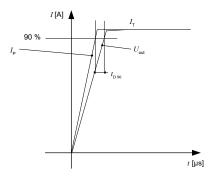
The maximum positive or negative discrepancy with a reference

straight line $U_{out} = f(I_P)$. Unit: linearity (%) expressed with full scale of I_{PN} .



Delay time $t_{D 90}$:

The time between the primary current signal (I_{PN}) and the output signal reach at 90 % of its final value.



Sensitivity:

The transducer's sensitivity \boldsymbol{S} is the slope of the straight line

 $U_{\text{out}} = f(I_{\text{P}})$, it must establish the relation:

$$U_{\rm out}(I_{\rm P}) = U_{\rm C}/5(S \times I_{\rm P} + U_{\rm O})$$

Offset with temperature:

The error of the offset in the operating temperature is the variation of the offset in the temperature considered with the initial offset at 25 $^{\circ}$ C.

The offset variation I_{OT} is a maximum variation the offset in the temperature range:

$$I_{OT} = I_{OE} \max - I_{OE} \min$$

The offset drift $\mathit{TCI}_{\rm O~E~AV}$ is the $\mathit{I}_{\rm O~T}$ value divided by the temperature range.

Sensitivity with temperature:

The error of the sensitivity in the operating temperature is the relative variation of sensitivity with the temperature considered with the initial offset at 25 °C.

The sensitivity variation S_{τ} is the maximum variation (in ppm or %) of the sensitivity in the temperature range: S_{τ} = (Sensitivity max – Sensitivity min) / Sensitivity at 25 °C. The sensitivity drift TCS_{AV} is the S_{τ} value divided by the temperature range. Deeper and detailed info available is our LEM technical sales offices (www.lem.com).

Offset voltage @ $I_p = 0$ A:

The offset voltage is the output voltage when the primary current is zero. The ideal value of $U_{\rm o}$ is $U_{\rm c}/2$. So, the difference of $U_{\rm o} - U_{\rm c}/2$ is called the total offset voltage error. This offset error can be attributed to the electrical offset (due to the resolution of the ASIC quiescent voltage trimming), the magnetic offset, the thermal drift and the thermal hysteresis. Deeper and detailed info available is our LEM technical sales offices (www.lem. com).

Environmental test specifications:

Refer to LEM GROUP test plan laboratory CO.11.11.515.0 with "Tracking_Test Plan_Auto" sheet.

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Environmental test specifications:

HAH1DRW 100-S/SP5...1500-S/SP5

Refer to LEM GROUP test plan laboratory CO.11.11.515.0 with "Tracking_Test Plan_Auto" sheet.

Name	Standard
CHARACTERIZATION	@ 25 °C (initial)
Sensitivity / Accuracy / Total error	LEM 98.20.00.574.0
Offset / Electrical Offset / Magnetic Offset	LEM 98.20.00.573.0
Linearity error	LEM 98.20.00.370.0
Current Consumption	LEM 98.20.00.579.0
CHARACTERIZATION	
Sensitivity / Accuracy / Total error	LEM 98.20.00.574.0
<i>T</i> °C variation of / Temperature Coefficient of <i>G</i>	LEM 98.20.00.574.0
Offset / Electrical Offset / Magnetic Offset	LEM 98.20.00.573.0
T°C variation of /Temperature Coefficient of Offset	LEM 98.20.00.573.0
Linearity error	LEM 98.20.00.370.0
Current Consumption	LEM 98.20.00.579.0
ELECTRICAL TES	STS @ 25 °C
Phase delay check	100 Hz to 100 KHz @ 20 A peak
Noise measurement	Sweep from DC to 1 MHz
Delay time d <i>i</i> /d <i>t</i>	100 A/ μ s. <i>I</i> pulse = $I_{P max}$
dv/dt	2000 V/µs. <i>U</i> = 2000 V
Dielectric Withstand Voltage test	2500 V AC / 1 min / 50 Hz
Insulation Resistance test	500 V DC, time = 60 s $R_{\rm INS} \ge$ 500 M Ω Minimum
ENVIRONMENTAL TE	STS (CLIMATIC)
	ISO 16750-4 § 5.3.2 (04/2010)
	500 cycles (500 hours),
Thermal shock	30 min @ −40 °C // 30 min @ +125 °C
	$U_{\rm c}$ not connected, $I_{\rm P}$ = 0
Steady state <i>T</i> °C Humidity bias life test	JESD 22-A 101 (03/2009)
MECHANICA	L TESTS
Vibration Random in <i>T</i> °C	ISO 16750-3 § 4.1.2.4(12/2012) 27.1 m/s², 8 h/axe 10 Hz -1000 Hz
	ISO 16750-3 § 4.2.2 (12/2012)
Shocks	50 g/ 6 ms Half Sine @ 25 °C
	10 shocks of each direction (Total: 60)
	$U_{\rm c}$ not connected, $I_{\rm p}$ = 0
Free Fall (Device not packaged)	IEC 60068-2-31 §5.2: method 1 (05/2008)
EMC	
Immunity to ElectroStatic Discharges (Handling of devices)	ISO 10605 (07/2008)
Immunity to Conducted disturbances (BCI)	ISO 11452-4 (12/2011)
Emission Radiated (ALSE)	CISPR 25 (03/2008)
FINAL CHARACT	ERIZATION
Characterization @ 25 °C	
Characterization with T °C	

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单击下面可查看定价,库存,交付和生命周期等信息

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